


<b>Search Notes</b>  	<b>Application/Control No.</b>  10649729	<b>Applicant(s)/Patent Under Reexamination</b>  SHIMIZU, KOICHI
	<b>Examiner</b>  Lay, Michelle K	<b>Art Unit</b>  2628

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
Updated EAST search (see detailed report)	01/23/2007	MKL
PLUS search	01/23/2007	MKL

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner